

**International Journal of Current
Microbiology and Applied Sciences
(IJCMAS) NAAS RATING-5.38, ICV-95.39**
ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online)

**An International, Monthly, Online, Free Access, Peer Reviewed,
Indexed, fast track Scientific Research Journal**

Certificate of Publication

This is to certify that the following article reviewed by editorial board and published in International Journal of Current Microbiology and Applied Sciences (IJCMAS) ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online).

Int.J.Curr.Microbiol.App.Sci.2017.6.(10):3592-3599

<https://doi.org/10.20546/ijcmas.2017.610.423>

Genetic Studies on the Effect of Slow Rusting Genes Lr34 and Lr68 on Minimizing Grain Yield Losses in Back Cross Segregating Populations of the Cross GW322 X Parula in Bread Wheat (*Triticum aestivum* L.)

Ashutosh Kumar¹, S.A. Desai^{1*}, Suma S. Biradar², K.J. Yashavantha Kumar³, P.V. Patil², V. Rudra Naik², T.N. Sathisha¹ and Bhumika N. Patel¹

¹Department of Genetics and Plant Breeding

²ICAR-AICRP on Wheat, MARS, University of Agricultural Sciences, Dharwad-580005, Karnataka, India

³Agharkar Research Institute, Pune, India



Dr. M. Prakash
Editor-in-chief

International Journal of Current Microbiology and Applied Sciences

www.ijcmas.com

www.excellentpublishers.com



© International Journal of Current Microbiology and Applied
Sciences (IJCMAS)

www.excellentpublishers.com www.ijcmas.com